

IPP60R520C6-VB Datasheet

N-Channel 650V (D-S) Super Junction Power MOSFET

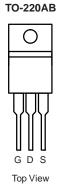
PRODUCT SUMMARY				
V _{DS} (V) at T _J max.	700			
R _{DS(on)} at 25 °C (Ω)	V _{GS} = 10 V 0.5			
Q _g max. (nC)	25			
Q _{gs} (nC)	2.0			
Q _{gd} (nC)	2.7			
Configuration	Single			

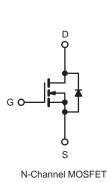
FEATURES

- Low figure-of-merit (FOM) Ron x Qa
- Low input capacitance (Ciss)
- · Reduced switching and conduction losses
- Ultra low gate charge (Qg)
- Avalanche energy rated (UIS)

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial





ABSOLUTE MAXIMUM RATINGS (T_C =	= 25 °C, uni	ess otherwis	se notea)		
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			V _{DS}	650	v
Gate-Source Voltage			V _{GS}	± 30	v
Continuous Drain Current (T. 150 °C)	V at 10 V	T _C = 25 °C	– I _D –	9	
Continuous Drain Current (T _J = 150 °C)	$V_{\rm GS}$ at 10 V	$T_C = 25 \text{ °C}$ $T_C = 100 \text{ °C}$		6	A
Pulsed Drain Current ^a			I _{DM}	21	
Linear Derating Factor				1.5	W/°C
Single Pulse Avalanche Energy ^b			E _{AS}	186	mJ
Maximum Power Dissipation			P _D	123	W
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C
Drain-Source Voltage Slope T _J = 125 °C		al\//alt	50		
Reverse Diode dV/dt d			dV/dt	4.5	V/ns
Soldering Recommendations (Peak Temperature) c for 10 s			300	°C	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature. b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 28.2 mH, $R_g = 25 \Omega$, $I_{AS} = 3.5 \text{ A}$. c. 1.6 mm from case. d. $I_{SD} \le I_D$, dI/dt = 100 A/µs, starting $T_J = 25 \text{ °C}$.



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	63	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.6	0/10	

PARAMETER	SYMBOL	TES	T CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static				•	•	•	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D = 250 μA	650	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _D = 1 mA	-	0.65	-	V/°C
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μΑ	2	-	4	V
			V _{GS} = ± 20 V	-	-	± 100	nA
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 30 \text{ V}$	-	-	± 1	μA
			= 600 V, V _{GS} = 0 V	-	-	1	<u> </u>
Zero Gate Voltage Drain Current	I _{DSS}		/, V _{GS} = 0 V, T _J = 125 °C	-	-	10	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	$I_D = 4 A$	-	0.50	-	Ω
Forward Transconductance	g _{fs}	V _{DS}	= 30 V, I _D = 4 A	-	16	-	S
Dynamic		•		1	1	1	
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	360	-	
Output Capacitance	C _{oss}		$V_{\rm GS} = 0.0$ V, $V_{\rm DS} = 100$ V,	-	25	-	
Reverse Transfer Capacitance	C _{rss}		f = 1 MHz	-	12	-	
Effective Output Capacitance, Energy Related ^a	C _{o(er)}			-	45	-	pF
Effective Output Capacitance, Time Related ^b	C _{o(tr)}	$ V_{DS} = 0$ V	V to 520 V, V _{GS} = 0 V	-	62	-	
Total Gate Charge	Qg			-	25		
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 4 \text{ A}, V_{DS} = 520 \text{ V}$	-	2.0	-	nC
Gate-Drain Charge	Q _{gd}			-	2.7	-	
Turn-On Delay Time	t _{d(on)}			-	25	-	
Rise Time	t _r	Vpp	= 520 V, I _D = 4 A,	-	55	-	
Turn-Off Delay Time	t _{d(off)}	00	$= 10 \text{ V}, \text{ R}_{\text{g}} = 9.1 \Omega$	-	70	-	ns
Fall Time	t _f			-	40	-	
Gate Input Resistance	Rg	f = 1	MHz, open drain	-	3.5	-	Ω
Drain-Source Body Diode Characteristic	s	- -					
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	-	7	
Pulsed Diode Forward Current	I _{SM}	integral revers p - n junction		-	-	18	A
Diode Forward Voltage	V _{SD}	T _J = 25 °	C, I _S = 4 A, V _{GS} = 0 V	-	-	1.5	V
Reverse Recovery Time	t _{rr}			-	190	-	ns
Reverse Recovery Charge	Q _{rr}	$\begin{array}{c c} & - & 190 \\ \hline \\ \hline \\ \hline \\ \\ \hline \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ $		-	μC		
Reverse Recovery Current	I _{RRM}	dl/dt = 1	100 Α/μs, V _R = 400 V		10		A

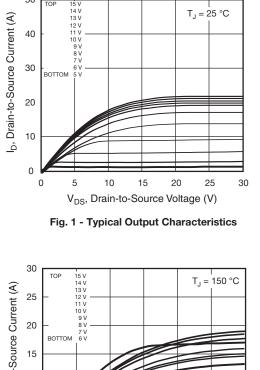
Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .

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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

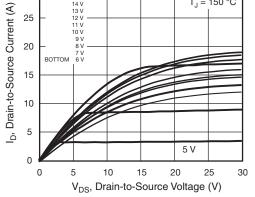


Fig. 2 - Typical Output Characteristics

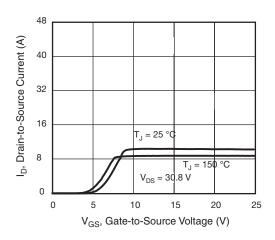


Fig. 3 - Typical Transfer Characteristics

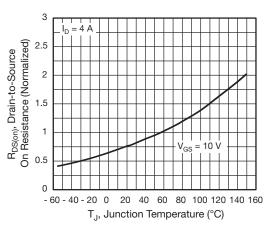


Fig. 4 - Normalized On-Resistance vs. Temperature

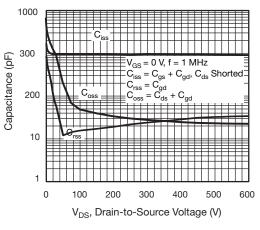


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

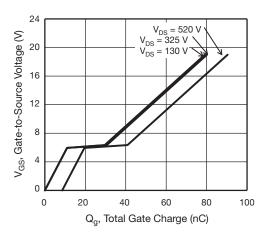


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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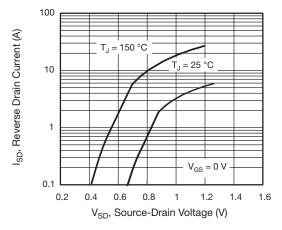


Fig. 7 - Typical Source-Drain Diode Forward Voltage



Fig. 8 - Maximum Safe Operating Area

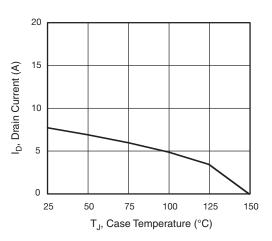


Fig. 9 - Maximum Drain Current vs. Case Temperature



Fig. 10 - Temperature vs. Drain-to-Source Voltage

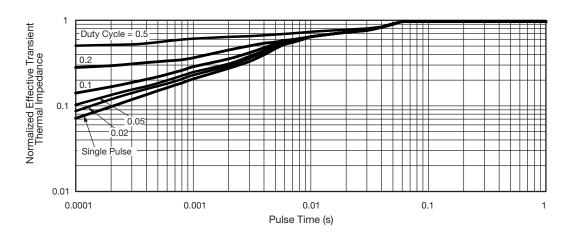


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



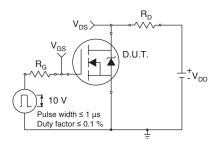


Fig. 12 - Switching Time Test Circuit



Fig. 13 - Switching Time Waveforms



Fig. 14 - Unclamped Inductive Test Circuit

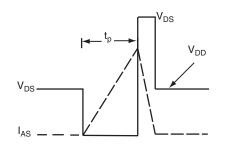


Fig. 15 - Unclamped Inductive Waveforms

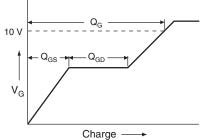


Fig. 16 - Basic Gate Charge Waveform

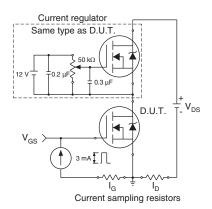
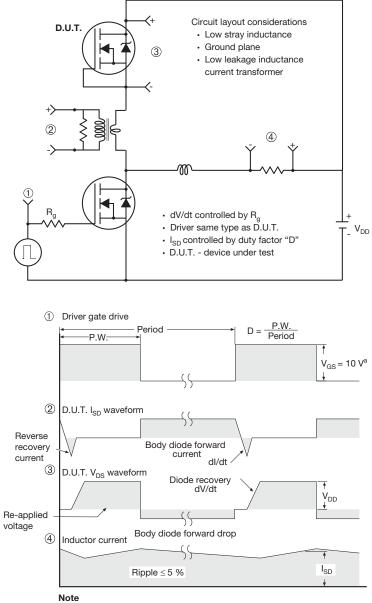


Fig. 17 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

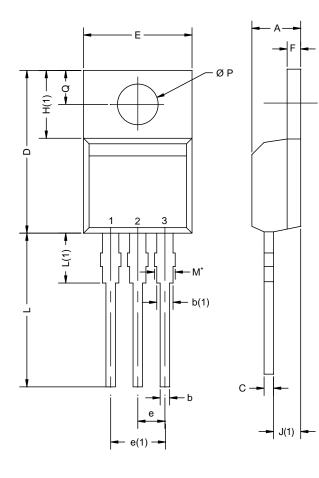


a. $V_{GS} = 5$ V for logic level devices

Fig. 18 - For N-Channel



TO-220AB



	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
А	4.25	4.65	0.167	0.183
b	0.69	1.01	0.027	0.040
b(1)	1.20	1.73	0.047	0.068
С	0.36	0.61	0.014	0.024
D	14.85	15.49	0.585	0.610
Е	10.04	10.51	0.395	0.414
е	2.41	2.67	0.095	0.105
e(1)	4.88	5.28	0.192	0.208
F	1.14	1.40	0.045	0.055
H(1)	6.09	6.48	0.240	0.255
J(1)	2.41	2.92	0.095	0.115
L	13.35	14.02	0.526	0.552
L(1)	3.32	3.82	0.131	0.150
ØΡ	3.54	3.94	0.139	0.155
Q	2.60	3.00	0.102	0.118
	0208-Rev. N,		0.102	0.11

Notes

* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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